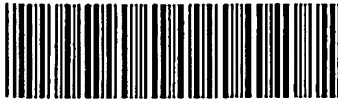


# Search Notes



Application/Control No.

10/509,563

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under Reexamination

KIM ET AL.

Art Unit

2832

## SEARCHED

Class	Subclass	Date	Examiner
439	217-218, 222-223, 650, 653	1/23/2006	TTN
<i>updated</i>	<i>—</i>	<i>6/8/06</i>	<i>TTN</i>

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
<i>Same as above</i>		<i>6/8/06</i>	<i>TTN</i>

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR